Search	h Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/849,251	FARIES ET AL.	
Examiner	Art Unit	
Mark W. Bockelman	3766	

SEARCHED			
Class	Subclass	Date	Examiner
604	113-	7-24-07	MB
374	208,147		
	148		
285	93		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
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